

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/768,783	LEE, CHANG-HWA	
Examiner		Art Unit		Page 1 of 1
Tse Chen		2116		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,922,451	05-1990	Lo et al.	714/8
*	B	US-2003/0005314	01-2003	Gammel et al.	713/189
*	C	US-2004/0186988	09-2004	Polyudov, Feliks	713/100
*	D	US-2004/0103272	05-2004	Zimmer et al.	713/001
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.